	Application No.	Applicant(s)	
Notice of Allowability	10/587,039	HOURAI ET AL.	
	Examiner	Art Unit	
	Felisa C. Hiteshew	4702	
	Felisa C. Hitesnew	1792	
The MAILING DATE of this communication app All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85 NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT F of the Office or upon petition by the applicant. See 37 CFR 1.31	S (OR REMAINS) CLOSED in i) or other appropriate communated RIGHTS. This application is su	this application. If not included nication will be mailed in due course. TH	IIS tiative
1. \boxtimes This communication is responsive to <u>the amendment filed</u>	d on 11/20/2007.		
2. The allowed claim(s) is/are <u>3-5,7 and 8</u> .			
3. ★ Acknowledgment is made of a claim for foreign priority u a) ★ All b) ☐ Some* c) ☐ None of the:		r (f).	
1. 🖾 Certified copies of the priority documents hav			
2. Certified copies of the priority documents have			
Copies of the certified copies of the priority do	ocuments have been received	in this national stage application from th	ne
International Bureau (PCT Rule 17.2(a)).			
* Certified copies not received:			
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDON! THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. 4. A SUBSTITUTE OATH OR DECLARATION must be subn	MENT of this application.		
INFORMAL PATENT APPLICATION (PTO-152) which giv	res reason(s) why the oath or	declaration is deficient.	
5. CORRECTED DRAWINGS (as "replacement sheets") mu	st be submitted.		
(a) \square including changes required by the Notice of Draftsper	son's Patent Drawing Review	(PTO-948) attached	
1) 🔲 hereto or 2) 🔲 to Paper No./Mail Date	_•		
(b) ☐ including changes required by the attached Examiner Paper No./Mail Date	's Amendment / Comment or i	n the Office action of	
Identifying indicia such as the application number (see 37 CFR each sheet. Replacement sheet(s) should be labeled as such in	1.84(c)) should be written on the the header according to 37 CFF	e drawings in the front (not the back) of 1.1.21(d).	
 DEPOSIT OF and/or INFORMATION about the deposit attached Examiner's comment regarding REQUIREMENT 	DISIT OF BIOLOGICAL MATE FOR THE DEPOSIT OF BIOL	RIAL must be submitted. Note the LOGICAL MATERIAL.	
Attachment(s) 1. ☐ Notice of References Cited (PTO-892)	E Notice of Infe	amal Datant Application	
 Notice of References Clied (PTO-092) Description of Notice of Draftperson's Patent Drawing Review (PTO-948) 		ormal Patent Application	
2. In Notice of Dranperson's Patent Drawing Neview (PTO-940)	6. ☐ Interview Sur Paper No./M		
 Information Disclosure Statements (PTO/SB/08), Paper No./Mail Date <u>09/05/2007</u> 	7. 🗌 Examiner's A	mendment/Comment	•
 Examiner's Comment Regarding Requirement for Deposit of Biological Material 		tatement of Reasons for Allowance	
	9.	Felisa C. Hiteshew Primary Examiner Art Unit: 1792	

Art Unit: 1792

Information Disclosure Statement

The PTOL 1449 of 09/05/2007 has been received, reviewed and considered.

Allowable Subject Matter

1. Claims 3-5, 7 and 8 are allowed.

The following is an examiner's statement of reasons for allowance: The prior art of record does not teach nor render obvious the instantly claimed invention. There is no teaching in the art to perform the processes that are now claimed. The prior art previously cited does not teach a method for growing silicon single crystals, comprising pulling a Silicon single crystal by the CZ method in a hydrogen-containing inert gas atmosphere so as to expand the range of the pull rate for the PI region at which a single crystal containing no COPs or dislocation clusters throughout the crystal in the radial direction having an interstitial rich region can be pulled, wherein the pulling of the silicon single crystal is conducted at a pull rate within an expanded range of the pull rate for the PI region so as to grow a grown-in defect-free silicon single crystal having a body portion that is an interstitial rich region, and the composition of the hydrogencontaining inert gas atmosphere is set so that the hydrogen concentration VH (vol%), air concentration VAir (vol%) and argon concentration VAr (vol%), when indicated as points (VH, VAr, VAir) in appended Fig. 12, are values which lie within a non- combustion range-enclosed by point A (100,0,0), point B (0,100,0), point C (0,0,100), point D (4,0,96), point E (4,84,12) and point F (75,0,25). There is no motivation in the art to change the prior art's teaching of to arrive at the instantly claimed process.

Application/Control Number: 10/587,039

Art Unit: 1792

Page 3

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Felisa Hiteshew whose telephone number is (571) 272-1463. The examiner can normally be reached on Mondays through Thursday from 5:30 AM to 4:00 PM with Fridays off.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Michael Barr, can be reached on (571) 272-1414. The fax phone number for the organization where this application or proceeding is assigned is (571) 273-1463.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system. see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866- 217-9197 (toll-free).

FELISA HITESHEW PRIMARY EXAMINER MANTES